

High Volume, Cost-Effective Production Testing of MMICs in the UK

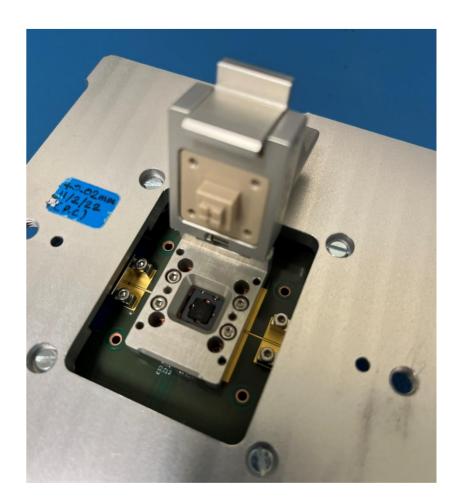
Robert Smith PRFI Ltd 5th November 2024

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Overview

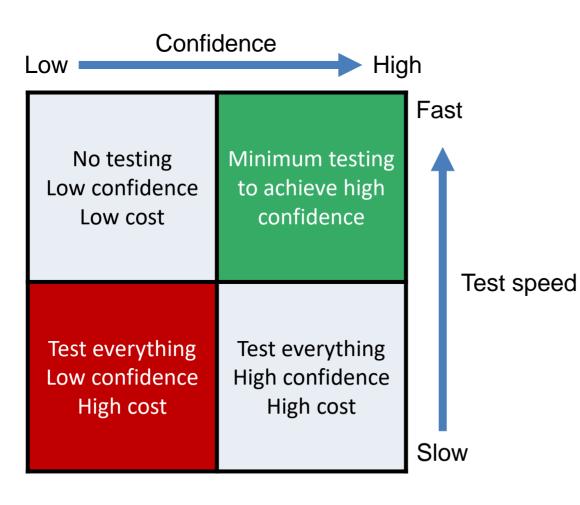


- Challenges of RF testing packaged ICs
- Production test cost reduction
- Test socket design
- Load-board design
- Production test correlation
- Test parameters & test procedure optimisation
- Automation
- Production test in action
- Summary





Challenges of Production Testing Packaged ICs at RF & Microwave Frequencies



Objective: Ensure quality of products shipped to customer

Technical Challenges:

- Achieving correlation between evaluation board performance and test socket performance
- Achieving repeatability between measurements
- Reducing impact of test socket and PCB

Where to Production Test?



"Why not just outsource production test?"

Several factors to consider:

- Labour costs higher in UK / Europe compared to Asia
- Supply chain resilience
- Flexibility
- Speed at which issues can be resolved
- Reputation

In-house testing is well suited to a broad product mix

Production Test Cost Reduction

- Reducing test time per IC
 - Auto-handlers
 - Parameters to test
 - Measurement test equipment settings
- Increasing automation
- Maximise uptime
 - Preventative maintenance
 - Reduce changeover times between products
 - Common hardware platform





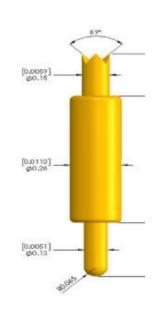


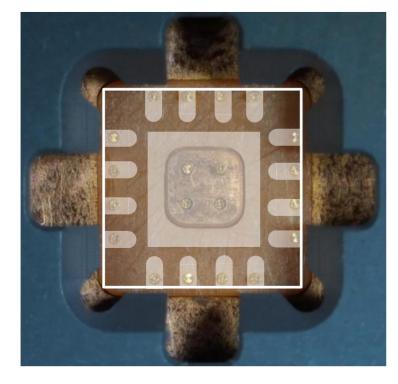
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Test Socket Design



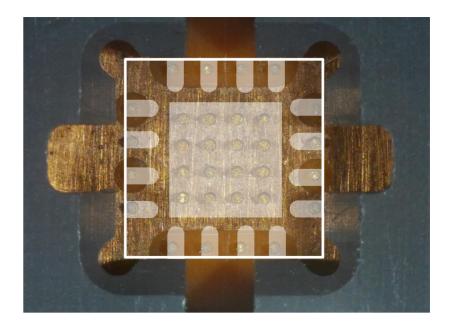
Initial design





Works to ~1 GHz

Revised design

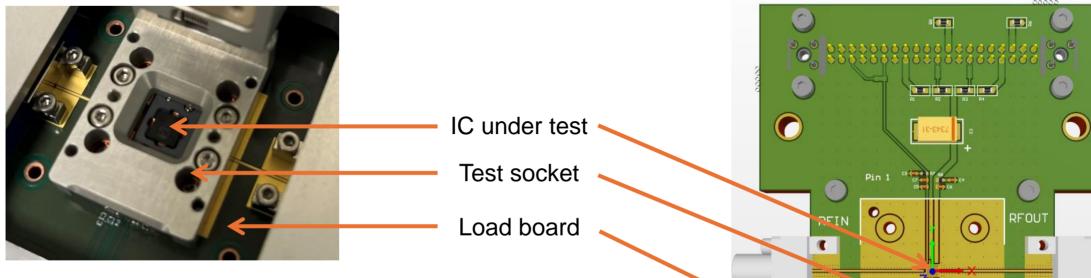


Works to ~30GHz

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Load Board Design



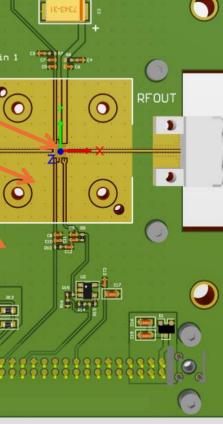


Factors to consider:

- Test socket footprint versus SMT component positions
- PCB stackup
- Connectors

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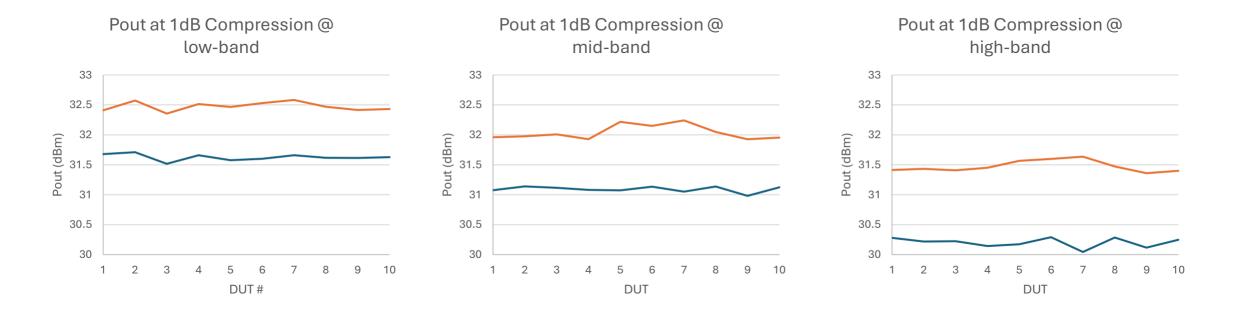
- Ease of use
- Commonality with other production test boards



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Production Test Correlation





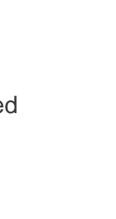
Performance of the device soldered onto the evaluation board Performance in the test socket using production test board

Possible Parameters to Test

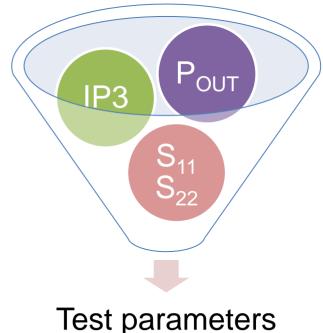
- DC parameters quiescent, standby mode
- S-Parameters

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- Large-signal performance CW or pulsed
- Two-tone performance (IP3)
- Modulated signal performance
- Considerations:
 - Time to conduct each measurement
 - Test equipment required
 - Test routines / automation that are required to be developed
 - Test in each mode/configuration?

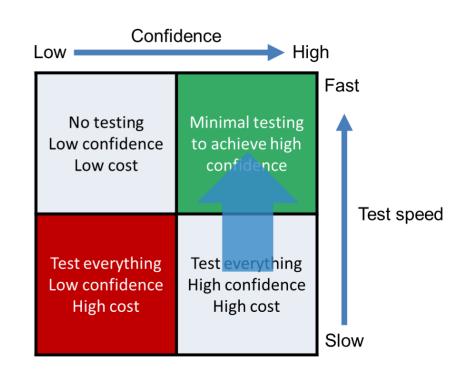






Test Procedure Optimisation

- Key question what is important to customers?
 - Some customers may have more stringent requirements than others
- Start with testing a more extensive set of parameters to ensure device is behaving as expected
- Once sufficient data has been gathered, look for patterns in the test data
- Reduce test time to speed up test throughput
 - Which parameters take longest to test?
 - Can we reduce the number of frequencies tested?
 - Can we eliminate a test parameter?





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Production Test Automation

Aim: Increase number of simultaneous test systems per operator

- Packaged part handler
- Tray handler
- Automated data storage, analysis and reporting
- Measurement system reliability and error reporting
 - If the system crashes, is data stored and progress saved?
 - Are error messages easy to understand and fix by the operator?
 - Does the system advise on when maintenance is required?





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Auto Handler







Tested Devices

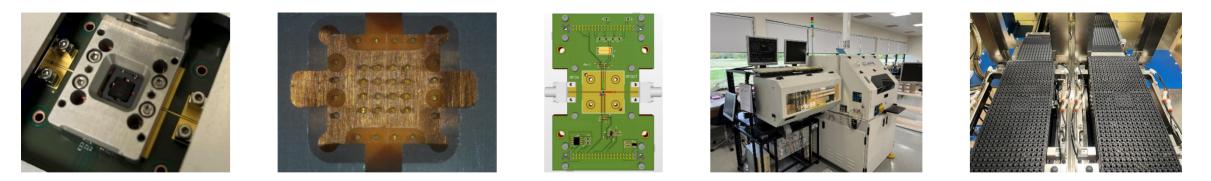




Summary



- Test sockets and production test boards have greater impact on production test performance at RF/microwave frequencies and require careful consideration
- Automation is key to keeping production test costs low
- Production test often a compromise between confidence and time/cost
- Careful consideration of which parameters to test can achieve low test costs and high product confidence
- Close collaboration between design team and production test team can highlight potential issues early and accelerate move to production



Thanks for your attention!



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